


<b>Search Notes</b>  	<b>Application/Control No.</b>  10617079	<b>Applicant(s)/Patent Under Reexamination</b>  FABRICK ET AL.
	<b>Examiner</b>  HIEP NGUYEN	<b>Art Unit</b>  3626

SEARCHED			
Class	Subclass	Date	Examiner
705	2, 3, 17	7/24/2008	HN

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
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